onsemi

<u>Silicon Carbide (SiC)</u> <u>MOSFET</u> – 80 mohm, 1200 V, M1, TO-247-4L NVH4L080N120SC1

Description

Silicon Carbide (SiC) MOSFET uses a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operation frequency, increased power density, reduced EMI, and reduced system size.

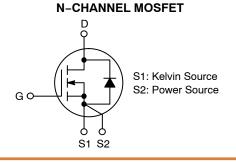
Features

- 1200 V @ $T_J = 175^{\circ}C$
- Max $R_{DS(on)} = 110 \text{ m}\Omega$ at $V_{GS} = 20 \text{ V}$, $I_D = 20 \text{ A}$
- High Speed Switching with Low Capacitance
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

Applications

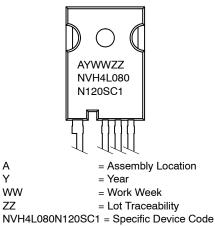
- Automotive Auxiliary Motor Drive
- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

| V _{DSS} | R _{DS(ON)} TYP | I _D MAX |
|------------------|-------------------------|--------------------|
| 1200 V | 80 mΩ | 29 A |





MARKING DIAGRAM



ORDERING INFORMATION

| Device | Package | Shipping |
|-----------------|-----------|--------------------|
| NVH4L080N120SC1 | TO-247-4L | 30 Units / Tube |

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, unless otherwise noted)

| Symbol | Parameter | | Ratings | Unit |
|-----------------------------------|---|----------------------------------|-------------|------|
| V _{DSmax} | Drain-to-Source Voltage | | 1200 | V |
| V _{GSmax} | Max. Gate-to-Source Voltage | @ T _C < 150°C | -15 / +25 | V |
| V _{GSop} (DC) | Recommended operation Values of Gate – Source Voltage | @ T _C < 150°C | -5 / +20 | V |
| V _{GSop} (AC) | Recommended operation Values of Gate – Source Voltage (f > 1 Hz) | @ T _C < 150°C | -5 / +20 | V |
| Ι _D | Continuous Drain Current | V_{GS} = 20 V, T_{C} = 25°C | 29 | А |
| | | V_{GS} = 20 V, T_{C} = 100°C | 21 | |
| I _{D(Pulse)} | Pulse Drain Current | Pulse width tp limited by Tj max | 125 | A |
| E _{AS} | Single Pulse Avalanche Energy (Note 1) | | 171 | mJ |
| P _{tot} | Power Dissipation | $T_{C} = 25^{\circ}C$ | 170 | W |
| | | T _C = 150°C | 28 | 1 |
| T _J , T _{STG} | Operating and Storage Junction Temperature | Range | –55 to +175 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. E_{AS} of 171 mJ is based on starting Tj = 25°C, L = 1 mH, I_{AS} = 18.5 A, , V_{DD} = 50 V, R_G = 25 Ω .

THERMAL CHARACTERISTICS

| Symbol | Parameter | Ratings | Unit |
|---------------------|---|---------|------|
| $R_{	ext{	heta}JC}$ | R _{0JC} Thermal Resistance, Junction-to-Case | | °C/W |
| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction-to-Ambient | 40 | |

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--------------------------------|--|--|------|-----|------------|----------|
| OFF CHARACT | ERISTICS | | | | | |
| BV _{DSS} | Drain-to-Source Breakdown Voltage | $I_D = 100 \ \mu A, \ V_{GS} = 0 \ V$ | 1200 | - | _ | V |
| $\Delta BV_{DSS}/\Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 5 \text{ mA}$, Referenced to 25°C | - | 0.3 | - | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V_{DS} = 1200 V, V_{GS} = 0 V T_C = 25°C T_C = 150°C | - | - | 100 1.0 | μA mA |
| I _{GSS} | Gate-to-Source Leakage Current | V_{GS} = 25 V, V_{DS} = 0 V | - | - | 1 | μΑ |
| I _{GSSR} | Gate-to-Source Leakage Current, Reverse | V_{GS} = -15 V, V_{DS} = 0 V | _ | - | -1 | μΑ |

ON CHARACTERISTICS

| V _{GS(th)} | Gate-to-Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 5 \text{ mA}$ | 1.8 | 2.75 | 4.3 | V |
|---------------------|--------------------------------------|--|-----|------|-----|----|
| R _{DS(on)} | Static Drain-to-Source On Resistance | V_{GS} = 20 V, I _D = 20 A | - | 80 | 110 | mΩ |
| | | V_{GS} = 20 V, I _D = 20 A, T _C = 150°C | - | 127 | 162 | |
| 9 FS | Forward Transconductance | V _{DS} = 20 V, I _D = 20 A | - | 11.3 | - | S |
| | | V_{DS} = 20 V, I _D = 20 A, T _C = 150°C | - | 9.8 | - | |

DYNAMIC CHARACTERISTICS

| C _{iss} | Input Capacitance | V_{DS} = 800 V, V_{GS} = 0 V, f = 1 MHz | - | 1112 | 1670 | pF |
|------------------|--------------------------------|---|---|------|------|----|
| C _{oss} | Output Capacitance | | - | 80 | 120 | pF |
| C _{rss} | Reverse Transfer Capacitance | | - | 6.5 | 10 | pF |
| E _{oss} | C _{oss} Stored Energy | | - | 32 | _ | μJ |

SWITCHING CHARACTERISTICS

| t _{d(on)} | Turn-On Delay Time | $V_{CC} = 800 \text{ V}, \text{ I}_{C} = 20 \text{ A},$ | - | 9 | 18 | ns |
|---------------------|-------------------------|---|---|------|----|----|
| t _r | Rise Time | $V_{GS} = -5/20 \text{ V}, \text{ R}_{G} = 4.7 \Omega$ Inductive Load, $T_{C} = 25^{\circ}C$ | - | 4.2 | 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | | - | 26.8 | 43 | ns |
| t _f | Fall Time | | - | 5.4 | 11 | ns |
| Eon | Turn-on Switching Loss | | - | 314 | - | μJ |
| E _{off} | Turn-off Switching Loss | | - | 32 | - | μJ |
| E _{ts} | Total Switching Loss | | - | 346 | - | μJ |
| Qg | Total Gate Charge | $V_{DD} = 600 \text{ V}, I_D = 20 \text{ A}$ | - | 56 | - | nC |
| Q _{gs} | Gate-to-Source Charge | V _{GS} = -5/20 V | - | 11 | - | nC |
| Q _{gd} | Gate-to-Drain Charge | | - | 12 | - | nC |
| R _G | Gate input resistance | f = 1 MHz, D–S short | - | 1.7 | - | Ω |

DIODE CHARACTERISTICS

| V_{SD} | Source-to-Drain Diode Forward | $V_{GS} = -5 V,$ | $T_{C} = 25^{\circ}C$ | _ | 3.7 | _ | V |
|------------------|-------------------------------|--------------------------------------|------------------------|---|-----|---|----|
| | Voltage | I _{SD} = 10 A | T _C = 150°C | - | 3.3 | - | |
| E _{rec} | Reverse Recovery Energy | $I_{SD} = 20 \text{ A},$ | T _C = 150°C | - | 29 | - | μJ |
| t _{rr} | Diode Reverse Recovery Time | $V_{GS} = -5 V,$ $V_{R} = 600 V,$ | $T_{C} = 25^{\circ}C$ | - | 18 | - | ns |
| | | dl _{SD} /dt = 1000 A/µs | T _C = 150°C | - | 31 | - | |
| Q _{rr} | Diode Reverse Recovery Charge | | $T_{C} = 25^{\circ}C$ | - | 80 | - | nC |
| | | | T _C = 150°C | - | 212 | - | |
| I _{rrm} | Peak Reverse Recovery Current | | $T_{C} = 25^{\circ}C$ | - | 9 | - | А |
| | | | T _C = 150°C | _ | 14 | - | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

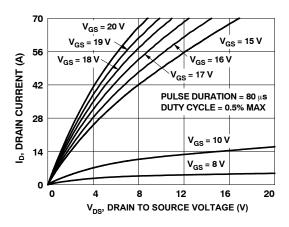


Figure 1. On Region Characteristics

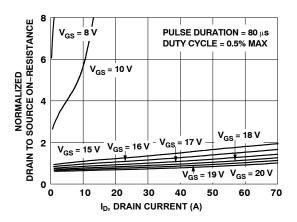
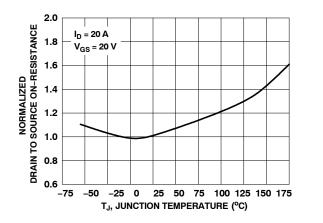


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage





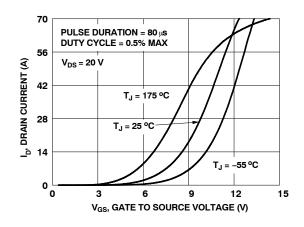


Figure 5. Transfer Characteristics

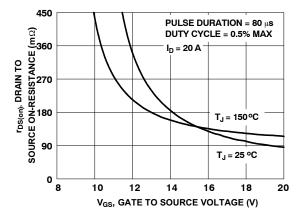


Figure 4. On-Resistance vs. Gate-to-Source Voltage

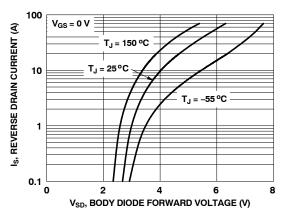


Figure 6. Source-to-Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

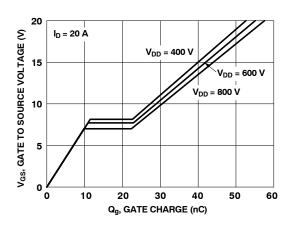


Figure 7. Gate Charge Characteristics

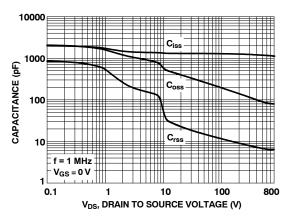


Figure 8. Capacitance vs. Drain-to-Source Voltage

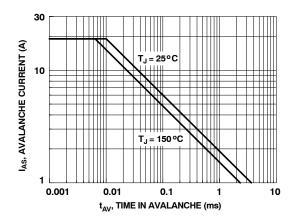


Figure 9. Unclamped Inductive Switching Capability

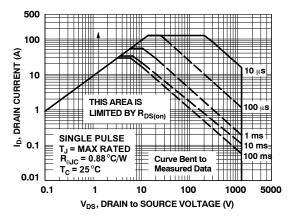


Figure 11. Forward Bias Safe Operating Area

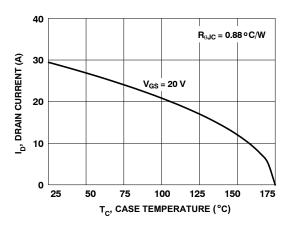
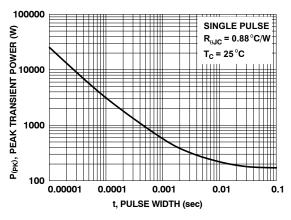


Figure 10. Maximum Continuous Drain Current vs. Case Temperature





TYPICAL CHARACTERISTICS $T_J = 25^{\circ}C$ unless otherwise noted (continued)

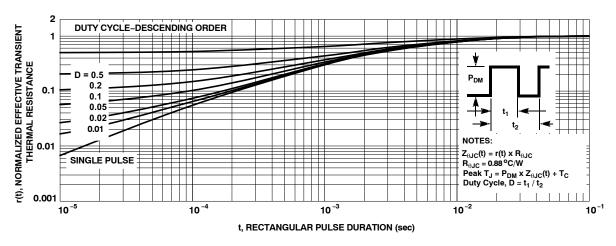
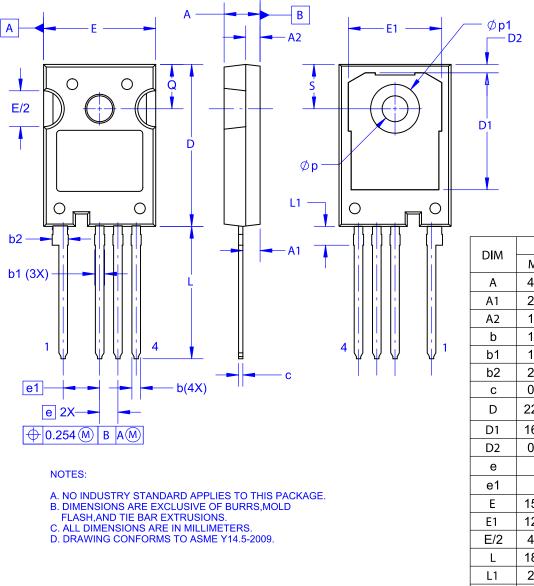


Figure 13. Junction-to-Case Transient Thermal Response Curve



TO-247-4LD CASE 340CJ ISSUE A

DATE 16 SEP 2019



| | MIL | LIMETER | S |
|-----|-------|----------|-------|
| DIM | MIN | NOM | MAX |
| А | 4.80 | 5.00 | 5.20 |
| A1 | 2.10 | 2.40 | 2.70 |
| A2 | 1.80 | 2.00 | 2.20 |
| b | 1.07 | 1.20 | 1.33 |
| b1 | 1.20 | 1.40 | 1.60 |
| b2 | 2.02 | 2.22 | 2.42 |
| С | 0.50 | 0.60 | 0.70 |
| D | 22.34 | 22.54 | 22.74 |
| D1 | 16.00 | 16.25 | 16.50 |
| D2 | 0.97 | 1.17 | 1.37 |
| е | 2 | 2.54 BSC | 2 |
| e1 | Ę | 5.08 BSC | 2 |
| Е | 15.40 | 15.60 | 15.80 |
| E1 | 12.80 | 13.00 | 13.20 |
| E/2 | 4.80 | 5.00 | 5.20 |
| L | 18.22 | 18.42 | 18.62 |
| L1 | 2.42 | 2.62 | 2.82 |
| р | 3.40 | 3.60 | 3.80 |
| p1 | 6.60 | 6.80 | 7.00 |
| Q | 5.97 | 6.17 | 6.37 |
| S | 5.97 | 6.17 | 6.37 |

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